

Silicon N-Channel Power MOSFET
General Description:

The HMC150N06 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is TO-262, which accords with the RoHS standard.

Features:

- **Fast Switching**
- **Low Gate Charge and Rdson**
- **Low Reverse transfer capacitances**
- **100% Single Pulse avalanche energy Test**

Applications:

Power switching application

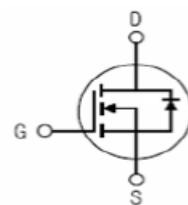
Hard switched and high frequency circuits

Uninterruptible power supply

V_{DSS}	60	V
I_D	150	A
P_D	220	W
$R_{DS(ON)}\text{type}$	3.5	$\text{m}\Omega$



Inner Equivalent Principium Chart


Absolute (Tc= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	60	V
I_D	Continuous Drain Current	150	A
	Continuous Drain Current Tc = 100 °C	105	A
I_{DM}	Pulsed Drain Current	600	A
V_{GS}	Gate-to-Source Voltage	± 20	V
$E_{AS} \text{ a2}$	Single Pulse Avalanche Energy	300	mJ
$E_{AR} \text{ a1}$	Avalanche Energy ,Repetitive	50	mJ
$I_{AR} \text{ a1}$	Avalanche Current	65	A
$dv/dt \text{ a3}$	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	220	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175	°C
T_L	MaximumTemperature for Soldering	300	°C

Electrical Characteristics (T_c = 25 °C unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	60	--	--	V
Δ BV _{DSS} / Δ T _J	Bvdss Temperature Coefficient	I _D =250μA, Reference 25°C	--	0.1	--	V/°C
I _{DSS}	Drain to Source Leakage Current	V _{DS} = 60V, V _{GS} = 0V, T _a = 25°C	--	--	1	μA
		V _{DS} = 48V, V _{GS} = 0V, T _a = 125°C	--	--	250	
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} = +20V	--	--	1	μA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} = -20V	--	--	-1	μA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =10V, I _D =75A	--	3.5	4.5	mΩ
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2.0	3.0	4.0	V
Pulse width t _p ≤ 380μs, δ ≤ 2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D = 75A	170	--	--	S
C _{iss}	Input Capacitance		--	6500	--	pF
C _{oss}	Output Capacitance	V _{GS} = 0V V _{DS} = 30V f = 1.0MHz	--	650	--	
C _{rss}	Reverse Transfer Capacitance		--	600	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D = 30A V _{DD} = 30V V _{GS} = 10V R _G = 2.5Ω	--	26	--	ns
tr	Rise Time		--	25	--	
t _{d(OFF)}	Turn-Off Delay Time		--	90	--	
t _f	Fall Time		--	40	--	
Q _g	Total Gate Charge	I _D = 30A V _{DD} = 30V V _{GS} = 10V	--	165	--	nC
Q _{gs}	Gate to Source Charge		--	30	--	
Q _{gd}	Gate to Drain ("Miller") Charge		--	65	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_s	Continuous Source Current (Body Diode)		--	--	150	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	600	A
V_{SD}	Diode Forward Voltage	$I_s=50A, V_{GS}=0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_s=40A, T_j = 25^\circ C$	--	45	--	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt=100A/\mu s, V_{GS}=0V$	--	70	--	nC
Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$						

Symbol	Parameter	Typ.	Units
$R_{\theta c}$	Junction-to-Case	1.8	°C/W

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: EAS condition : $T_j=25^\circ C, V_{DD}=30V, V_G=10V, L=0.5mH, R_g=25\Omega$

^{a3}: $I_{SD} = 150A, dI/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}$, Start $T_j=25^\circ C$

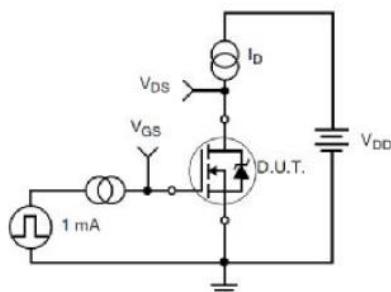
Test Circuit and Waveform


Figure 17. Gate Charge Test Circuit

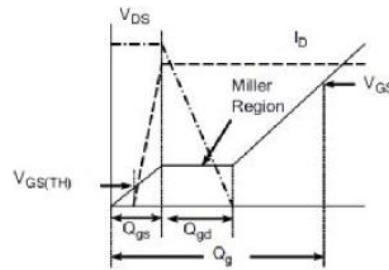


Figure 18. Gate Charge Waveform

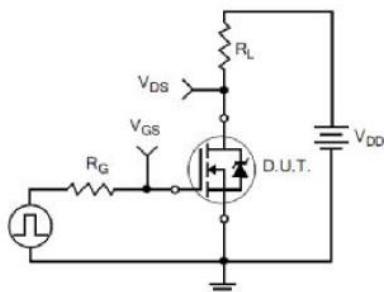


Figure 19. Resistive Switching Test Circuit

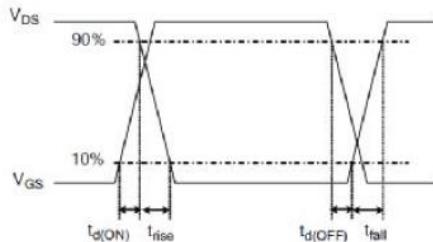
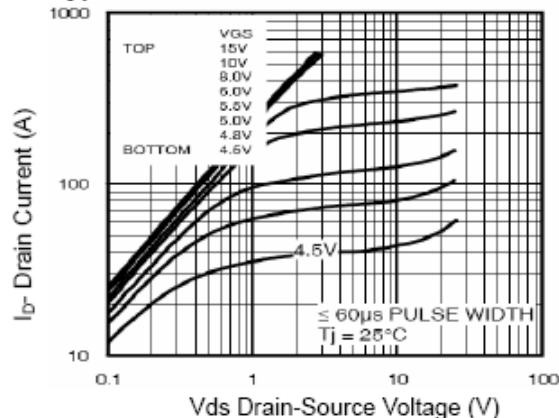
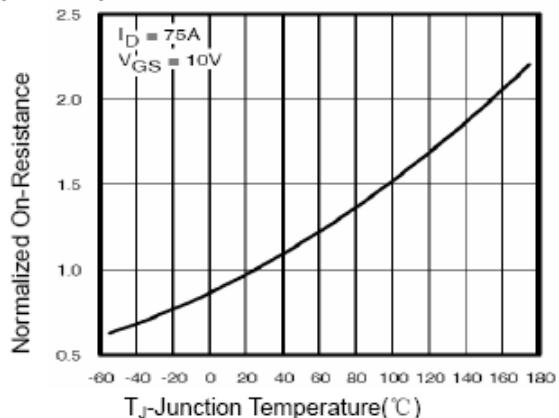
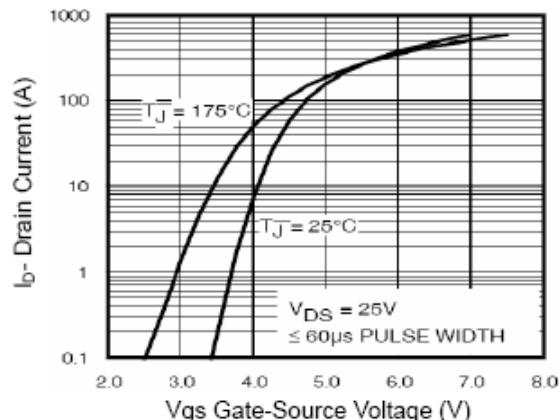
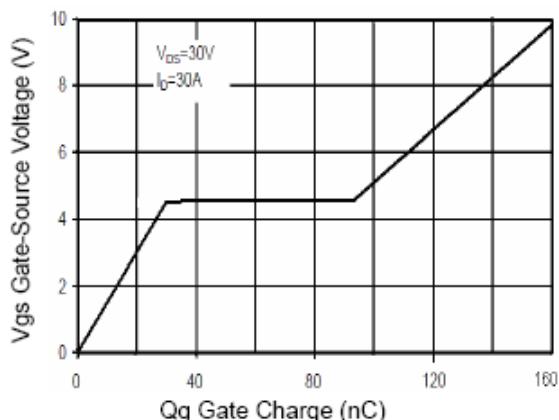
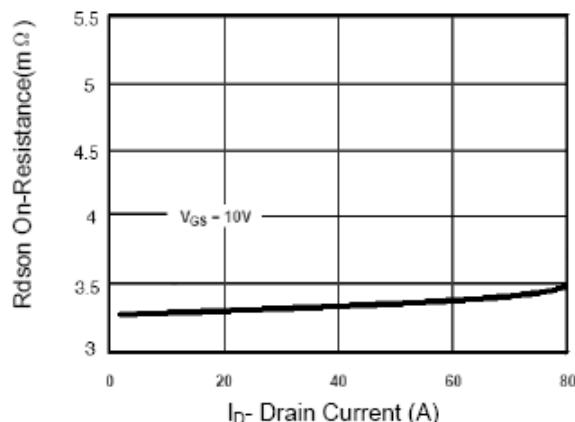
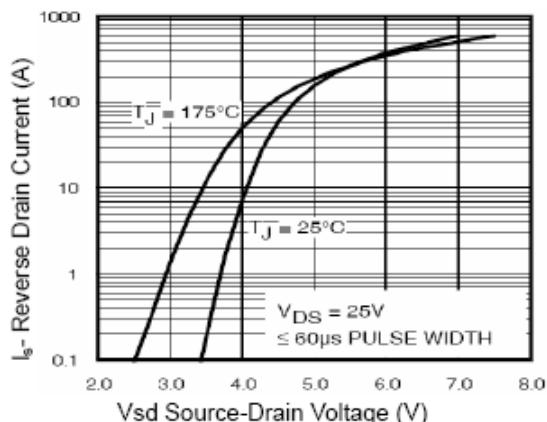


Figure 20. Resistive Switching Waveforms

Typical Electrical and Thermal Characteristics (Curves)

Figure 1 Output Characteristics

Figure 4 Rdson-JunctionTemperature

Figure 2 Transfer Characteristics

Figure 5 Gate Charge

Figure 3 Rdson- Drain Current

Figure 6 Source- Drain Diode Forward

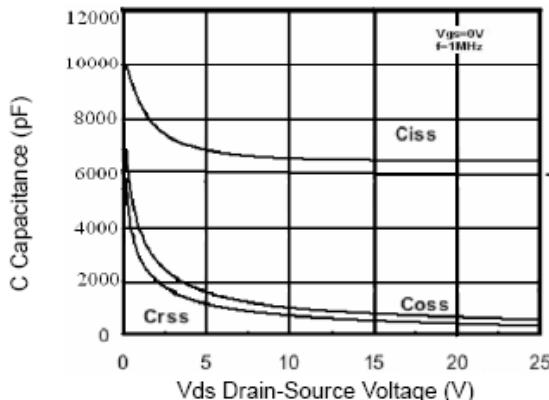


Figure 7 Capacitance vs Vds

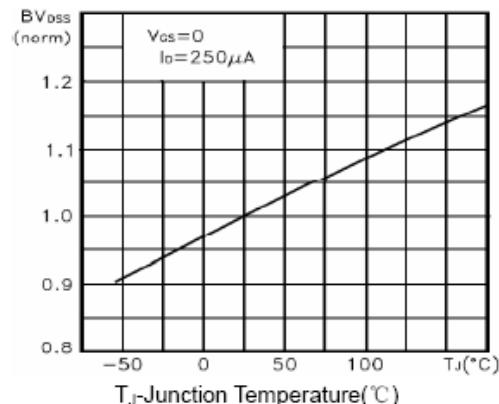


Figure 9 BV_{dss} vs Junction Temperature

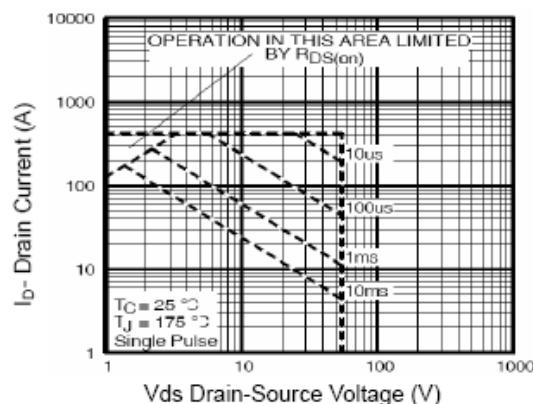


Figure 8 Safe Operation Area

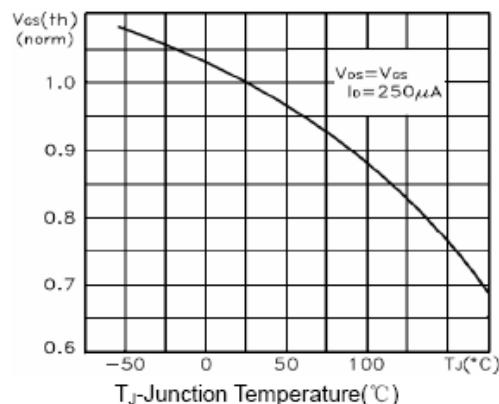


Figure 10 $V_{GS(th)}$ vs Junction Temperature

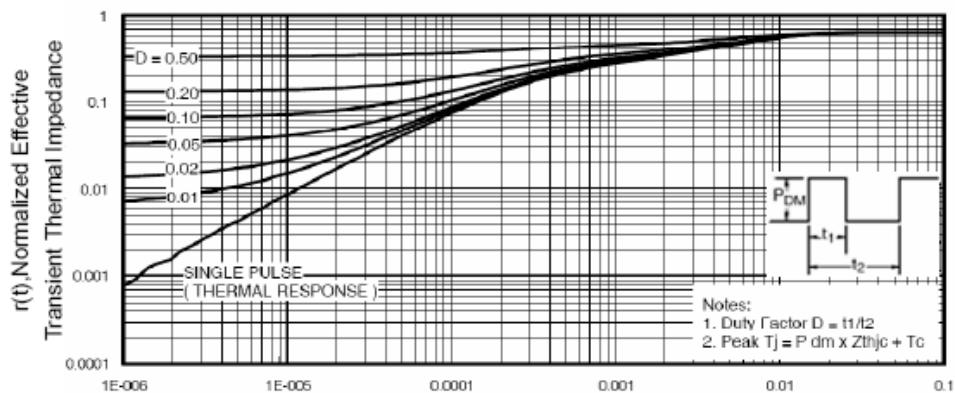


Figure 11 Normalized Maximum Transient Thermal Impedance